

Notice of References Cited	Application/Control No. 09/934,004	Applicant(s)/Patent Under Reexamination LI ET AL.	
	Examiner Le Nguyen	Art Unit 2174	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2004/0125124	07-2004	Kim et al.	345/716
	B	US-6,556,767	04-2003	Okayama et al.	386/31
	C	US-			
	D	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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